Linear Classifiers II

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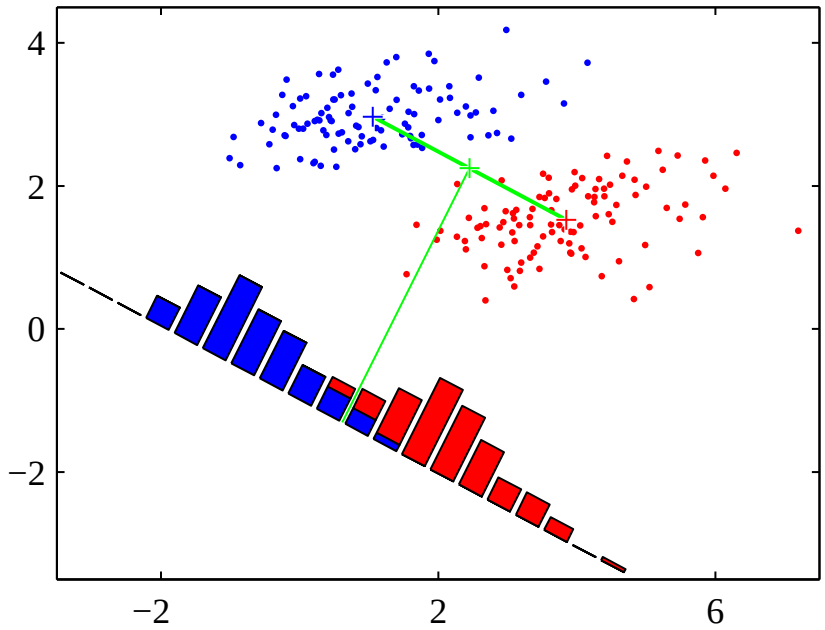
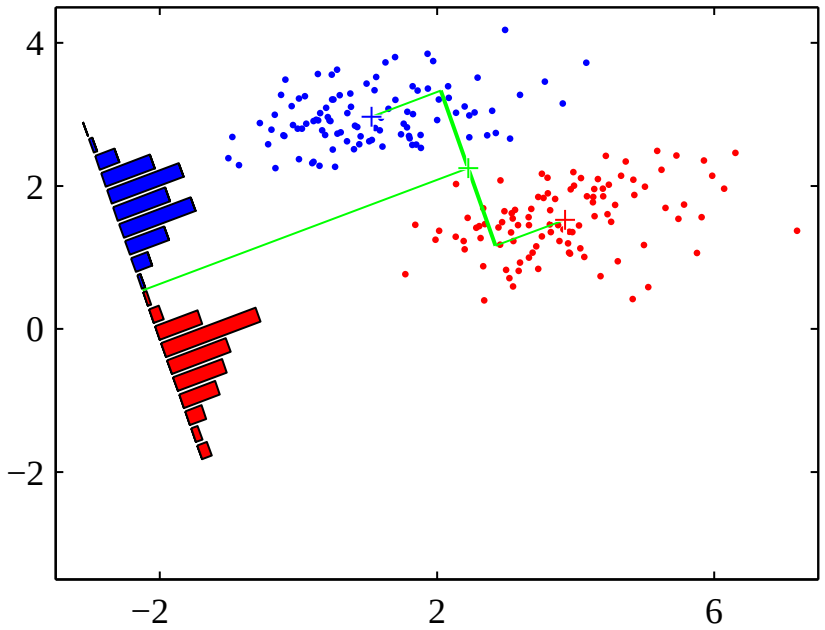
Linear Classifiers - supplement lecture

- Supplement to the lecture about learning Linear Classifiers (perceptron, . . .)
- Better etalons by applying Fischer linear discriminator analysis.
- LSQ formulation of the learning task.

Fischer linear discriminant

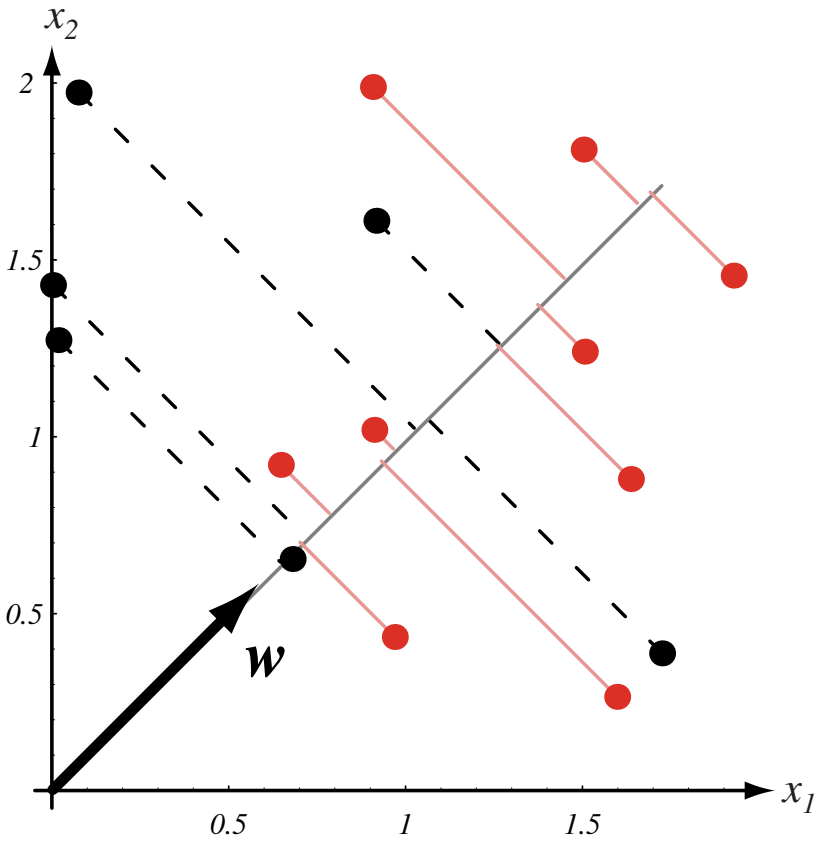


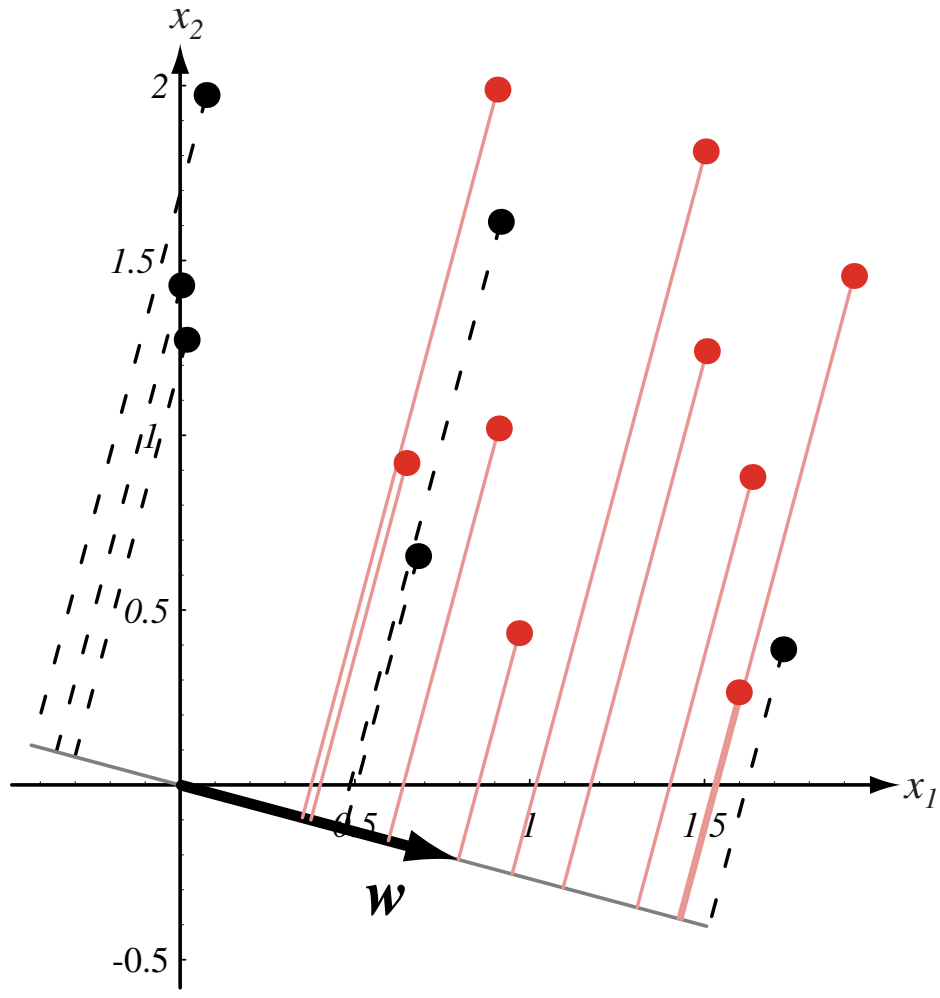


- Dimensionality reduction
- Maximize distance between means, . . .
- . . . and minimize within class variance. (minimize overlap)

Figures from [1]

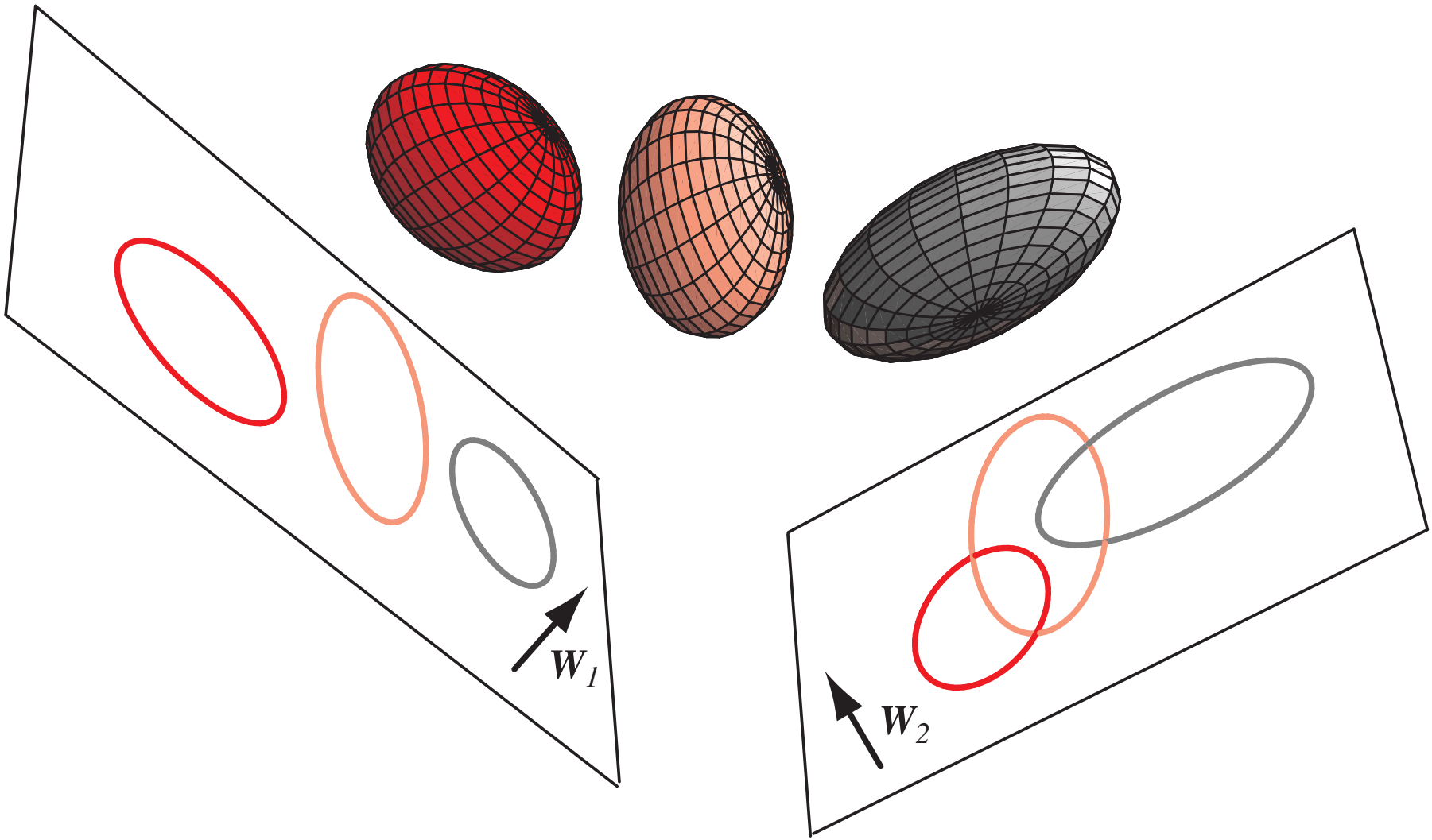
Projections to lower dimensions $y = \mathbf{w}^\top \mathbf{x}$





Figures from [2]

Projections to lower dimensions $y = \mathbf{w}^\top \mathbf{x}$



Figures from [2]

Finding the best projection

$$y = \mathbf{w}^\top \mathbf{x}$$

thresholding $y \geq -w_0$ C_1, otherwise C_2

$$\mathbf{m}_i = \frac{1}{n_i} \sum_{\mathbf{x} \in C_i} \mathbf{x}$$

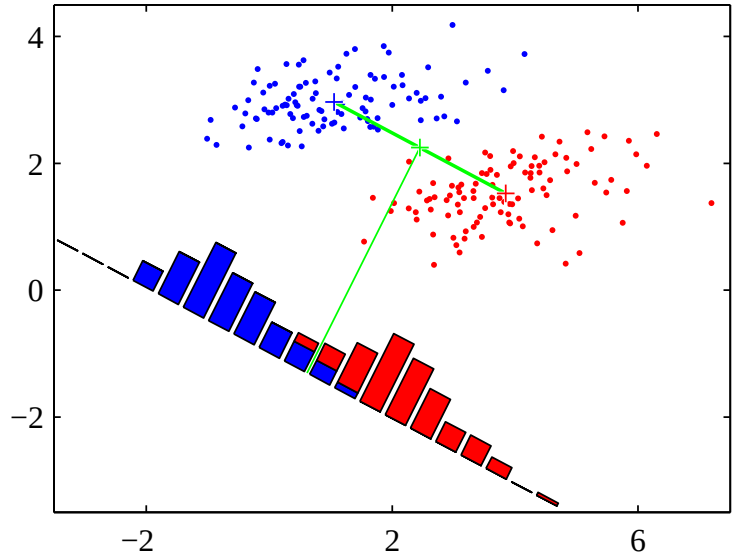
$$m_2 - m_1 = \mathbf{w}^\top (\mathbf{m}_2 - \mathbf{m}_1)$$

Within class scatter of projected samples

$$s_i^2 = \sum_{y \in C_i} (y - m_i)^2$$

Fischer criterion:

$$J(\mathbf{w}) = \frac{(m_2 - m_1)^2}{s_1^2 + s_2^2}$$



$$\mathrm{S}_i = \sum_{x \in C_1} (\mathbf{x} - \mathbf{m}_i)(\mathbf{x} - \mathbf{m}_i)^\top$$

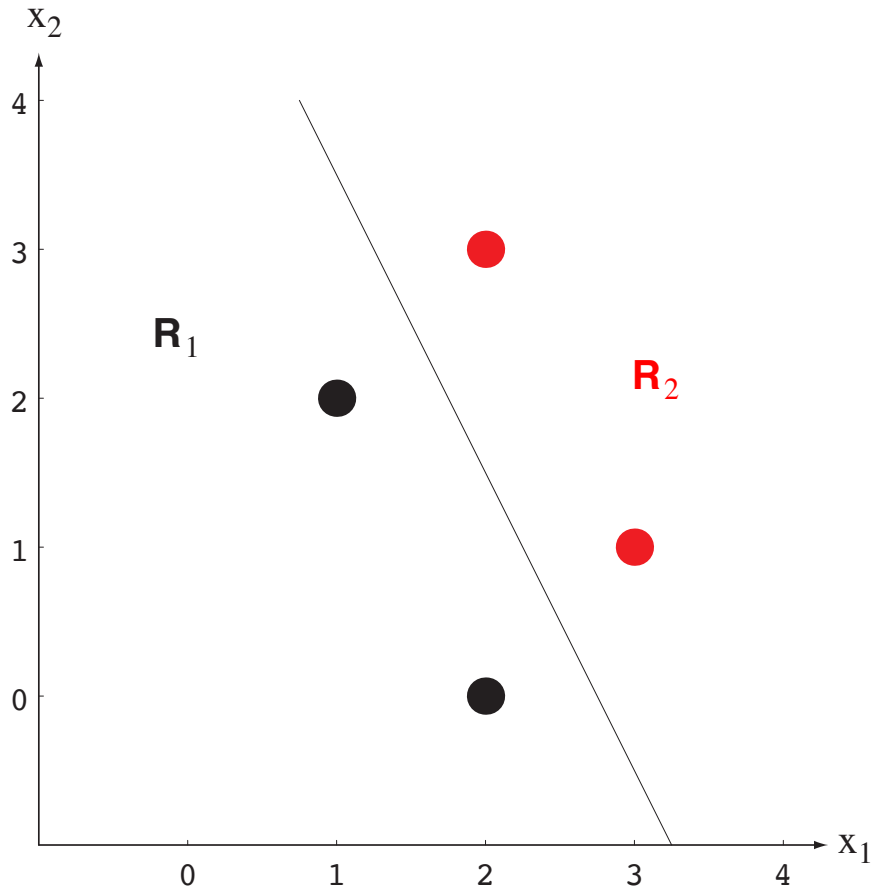
$$\mathrm{S}_W = \mathrm{S}_1 + \mathrm{S}_2$$

$$\mathrm{S}_B = (\mathbf{m}_2 - \mathbf{m}_1)(\mathbf{m}_2 - \mathbf{m}_1)^\top$$

$$J(\mathbf{w}) = \frac{\mathbf{w}^\top \mathrm{S}_B \mathbf{w}}{\mathbf{w}^\top \mathrm{S}_W \mathbf{w}}$$

LSQ approach to linear classification

$$\mathbf{X}\mathbf{w} = \mathbf{b}$$



References I

Further reading: Chapter 18 of [4], or chapter 4 of [1], or chapter 5 of [2]. Many Matlab figures created with the help of [3]. You may also play with demo functions from [5].

[1] Christopher M. Bishop.
Pattern Recognition and Machine Learning.
Springer Science+Bussiness Media, New York, NY, 2006.
PDF freely downloadable.

[2] Richard O. Duda, Peter E. Hart, and David G. Stork.
Pattern Classification.
John Wiley & Sons, 2nd edition, 2001.

[3] Votjěch Franc and Václav Hlaváč.
Statistical pattern recognition toolbox.
`http://cmp.felk.cvut.cz/cmp/software/stprtool/index.html`.

References II

[4] Stuart Russell and Peter Norvig.
Artificial Intelligence: A Modern Approach.
Prentice Hall, 3rd edition, 2010.
http://aima.cs.berkeley.edu/.

[5] Tomáš Svoboda, Jan Kybic, and Hlaváč Václav.
Image Processing, Analysis and Machine Vision — A MATLAB Companion.
Thomson, Toronto, Canada, 1st edition, September 2007.
http://visionbook.felk.cvut.cz/.